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Form Y&T (3/94)

Page 1 of 1 ATTY. DOCKET NO. SEBIAL NO. FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE 8029-1026 09/994,852 PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE APPLICANT Hizuru NAWATA STATEMENT BY APPLICANT (Use several sheets if necessary) 37 CFR 1.98(b) GROUP FILING OATED November 28, 2001 2681 U.S. PATENT DOCUMENTS ISSUE SUB FILING DATE EXAMINER IF APPROPRIATE INITIAL DATE PATENTEE CLASS CLASS PATENT NUMBER 07/99 Ducharme et al. 5,930,515 AA ナル 07/99 5,930,704 Kay AB 02/99 Philips et al. 5,872,810 AC 5,666,293 09/97 Metz et al. AD FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION TRANSLATION PUBL. SUB YES NO DATE COUNTRY OR PATENT OFFICE CLASS CLASS DOCUMENT NO. 99/23820 05/99 Αl 06/93 JP 05158703 English ΑJ abstract AK AL AM AN AO AP AQ OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication) AT ΑU

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<sup>\*</sup> Abstract provided for the Examiner's convenience